


<b>Search Notes</b>  	<b>Application/Control No.</b>  09848953	<b>Applicant(s)/Patent Under Reexamination</b>  HICKERSON ET AL.
	<b>Examiner</b>  Chawan, Sheela C	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	155,309,292	6/7/07	SCC
704	227,228,256	"	"
ABOVE SEARCH UPDATE.		"	"

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCH EAST AND OTHER DATABASE SEE THE ATTACHED SEARCH HISTORY.	6/7/07	SCC
382/187,155,173,229,292,309.CCLS.	6/7/07	SCC
704/232,227,228,256.CCLS. US-	"	"
PATENT ONLY, SEE TEXT SEARCH.	"	"
INTERFERENCE SEARCH, SEE SEARCH HISTORY PRINTOUT.	"	"
INVENTOR NAME SEARCH.	"	"
IEEE OR INSPEC DATA BASE SEARCH.	"	"
ABOVE SEARCH UP-DATE.	"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	155,309,292	6/7/07	SCC
704	227,228,256	"	"